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<b>Notice of References Cited</b>	Application/Control No. 10/645,703	Applicant(s)/Patent Under Reexamination LAI, HAN-CHUNG	
	Examiner Dung Nguyen	Art Unit 2871	Page 1 of 1

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	C	US-2003/0122983	07-2003	Kim et al.	349/43
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**NON-PATENT DOCUMENTS**

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